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INFORMATION DISCLOSURE CITATION	Applicant: Hirokazu IKEDA et al	Filed: Unknown	JCI7R PCT/PTO 29 MAR 2005 10/529698
	Ser. No.: Unknown	Atty. Ref.: Furuya Case 1419	
	Conf. No.: Unknown		
	Group: Unknown		

## U.S. PATENT DOCUMENTS

Examiner Initial*	Document Number	Date	Name	Class	Sub Class	Filing Date
EGT	AA 6 136 925	10/2000	MULLER et al			
	AB					
	AC					

## FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Sub Class	Translation Yes No
EGT	AD 3-2009	1/1991	Japan	English Abstract attached		
EGT	AE 63-84626	4/1988	Japan	English Abstract attached		
EGT	AF 2001-124752	5/2001	Japan	English Abstract attached		
EGT	AG 10-158200	6/1998	Japan	English Abstract attached		
EGT	AH 63-171678	7/1988	Japan	English Abstract attached		
EGT	AI EP 0 656 333	6/1995	Europe			
EGT	AJ EP 1 391 239	2/2004	Europe			
EGT	AK EP 1 334 967	8/2003	Europe			
EGT	AL WO 96/14151	5/1996	WIPO	English Abstract attached		
EGT	AM WO 02/30903	4/2002	WIPO	English Abstract attached		
EGT	AN WO 02/083298	10/2002	WIPO	English Abstract attached		

## OTHER DOCUMENTS (Including Author, Title, Date, Pages, Etc.)

EGT	AO	Useful Chiral Packing Materials for High-Performance Liquid Chromatographic Resolution of Enantiomers: Phenylcarbamates of Polysaccharides Coated on Silica Gel, by Yoshio OKAMOTO et al, J. Am. Chem. Soc., Vol. 106, No. 18, 1984, pgs. 5357-5359
	AP	

EXAMINER

E. THERKORN

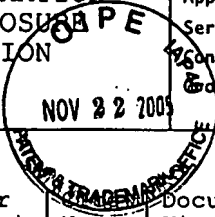
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## U.S. PATENT DOCUMENTS

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	AG			
	AH			
	AI			

## FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
EGT	AJ	EP 0 254 811 A	02-03-1988	Raghunathan, et al.	
EGT	AK	EP 1 496 356 A	01-12-2005	Onishi, et al.	
	AL				
	AM				
	AN				

## NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	(Include Author, Title, Date, Pages, Etc.)
EGT	AO	European Patent Office Search Report dated September 6, 2005 (3 pages)
	AP	
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